#### Hardness vs. Randomness

Shubham Sharma\*, Rahul Gupta\*

\*Indian Institute of Technology Kanpur, India

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<sup>&</sup>lt;sup>1</sup>https://www.math.ias.edu/avi/node/780 Noam Nisan and Avi Wigderson

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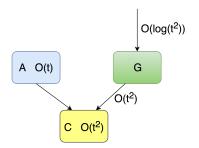
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  - quality of the output  $n, \epsilon$
  - price r

• If there exists a quick pseudorandom generator  $G : \log(n) \to n$  then for any time constructible bound t = t(n):

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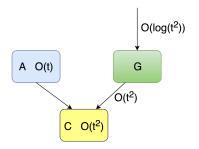
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 Simulate A deterministically, by trying all the possible random seeds and taking a majority vote

## **Applications**



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- BPP  $\subset \cap_{\epsilon>0} \mathsf{DTIME}(2^{n^{\epsilon}})$
- $\bullet \ \mathsf{BPP} \subset \mathsf{DTIME}(2^{(\log n)^c})$
- BPP = P
- RNC  $\subset \cap_{\epsilon>0} \mathsf{DSPACE}(n^{\epsilon})$
- RNC ⊂ DSPACE(polylog):

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- Shamir: RSA function
- Blum and Micali: Intractability of Discrete Logarithm function
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  - Require a strong unproven assumption. (the existence of a one-way function, an assumption which is even stronger than P  $\neq$  NP)
  - sequential

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- Let  $f_1, \dots, f_k$  all be  $(\epsilon, S)$ -hard. Then for any  $\delta > 0$ , the function  $f(x_1, \cdot, x_k)$  defined by

$$f(x_1,\cdot,x_k)=\sum_{i=i}^k f_i(x_i) (mod \ 2)$$

is 
$$(\epsilon^k + \delta, \delta^2(1 - \epsilon)^2 S)$$
-hard



• Let  $f = \{0,1\}^* \to \{0,1\}$  be a boolean function. We say that f cannot be approximated by circuits of size s(n) if for some constant k, all large enough n, and all circuits  $C_n$  of size s(n):

$$\Pr[C_n(x) \neq f(x)] > n^{-k}$$

- small circuits attempting to compute f have a non-negligible fraction of error
- Let  $f:\{0,1\}^* \to \{0,1\}$  be a boolean function, and let  $f_m$  be the restriction of f to strings of length m. The Hardness of f at m,  $H_{f(m)}$  is defined to be the maximum integer  $h_m$  such that fm is  $(1/h_m, h_m)$ -hard

• Let s(m) be any function such that  $m \le s(m) \le 2^m$ ; if there exists a function f in EXPTIME that cannot be approximated by circuits of size s(m), then for some c > 0 there exists a function f' in EXPTIME that has hardness  $H_{f'(m)} \ge s(m^c)$ .

• A collection of sets  $\{S_1, \dots, S_n\}$ , where  $S_i \subset \{1, \dots, l\}$  is called a (k, m)-design if:

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- \forall i: |S_i| = m 

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  - $-G:I \rightarrow n$  given by  $G(x)=f_{A(x)}$  is a pseudorandom generator
  - $-f_{A(x)}$  the *n* bit vector of bits computed by applying the function *f* to the subsets of the x's denoted by the *n* different rows of *A*

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- Construct the circuit that predicts the next bit of  $f_{A(x)}$
- This contradicts that  $H_{f(m)} \geq n^2$

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  - For some c>0 there exists a function in EXPTIME with hardness  $s(I^c)$
  - For some c > 0 there exists a quick pseudorandom generator  $G: I \rightarrow s(I^c)$

### Message from Octopus



Questions?